

General Description

- Trench Power MOSFET - AlphaSGT™ technology
- Combined of low $R_{DS(ON)}$ and wide safe operating area (SOA)
- Higher in-rush current enabled for faster start-up and shorter down time
- RoHS and Halogen-Free Compliant

Applications

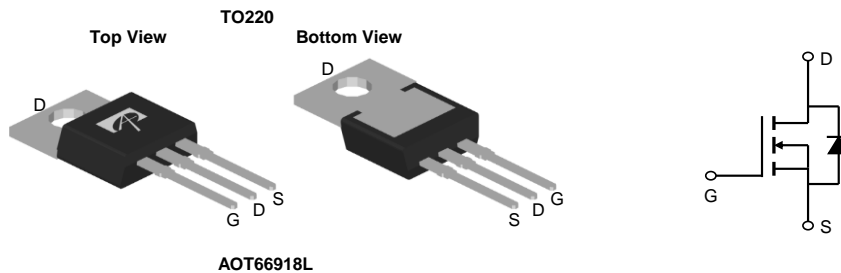
- Telecom
- Industrial Power Supply
- Load switch

Product Summary

V_{DS}	100V
I_D (at $V_{GS}=10V$)	120A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 5mΩ
$R_{DS(ON)}$ (at $V_{GS}=8V$)	< 5.6mΩ

100% UIS Tested
 100% Rg Tested

Max $T_J=175^{\circ}C$



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT66918L	TO-220	Tube	1000

Absolute Maximum Ratings $T_A=25^{\circ}C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current ^G	I_D	$T_C=25^{\circ}C$	120
		$T_C=100^{\circ}C$	120
Pulsed Drain Current ^C	I_{DM}	480	A
Continuous Drain Current	I_{DSM}	$T_A=25^{\circ}C$	33
		$T_A=70^{\circ}C$	27
Avalanche Current ^C	I_{AS}	70	A
Avalanche energy $L=0.3mH$ ^C	E_{AS}	735	mJ
Diode reverse recovery $V_{DS}=0$ to 50V, $I_F \leq 300A$, $T_J \leq 125^{\circ}C$	di/dt	500	A/us
Power Dissipation ^B	P_D	$T_C=25^{\circ}C$	375
		$T_C=100^{\circ}C$	185
Power Dissipation ^A	P_{DSM}	$T_A=25^{\circ}C$	10
		$T_A=70^{\circ}C$	7
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	$^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A $t \leq 10s$	$R_{\theta JA}$	12	15	$^{\circ}C/W$
Maximum Junction-to-Ambient ^{A,D} Steady-State		50	60	$^{\circ}C/W$
Maximum Junction-to-Case Steady-State	$R_{\theta JC}$	0.26	0.40	$^{\circ}C/W$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	100			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.7	3.2	3.7	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A T _J =125°C		4.2 7.7	5 9.4	mΩ
		V _{GS} =8V, I _D =20A		4.6	5.6	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A		50		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.68	1	V
I _S	Maximum Body-Diode Continuous Current ⁶				120	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz		6500		pF
C _{oss}	Output Capacitance			3200		pF
C _{rss}	Reverse Transfer Capacitance			30		pF
R _g	Gate resistance	f=1MHz	1.1	2.3	3.5	Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A		75	105	nC
Q _{gs}	Gate Source Charge			25		nC
Q _{gd}	Gate Drain Charge			15		nC
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =50V		242		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =50V, R _L =2.5Ω, R _{GEN} =3Ω		26		ns
t _r	Turn-On Rise Time			23		ns
t _{D(off)}	Turn-Off DelayTime			53		ns
t _f	Turn-Off Fall Time			28		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		80		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		790		nC

- A. The value of R_{θJA} is measured in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} ≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.
- B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.
- D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

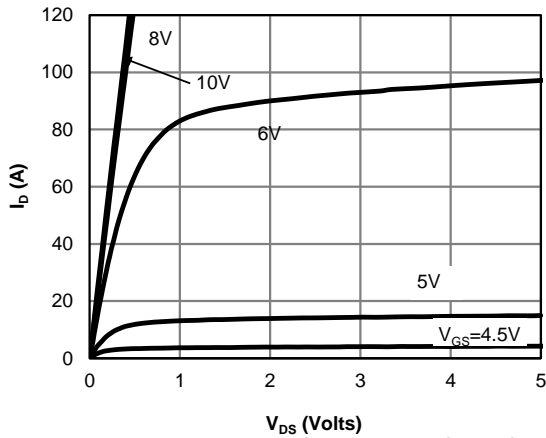


Figure 1: On-Region Characteristics (Note E)

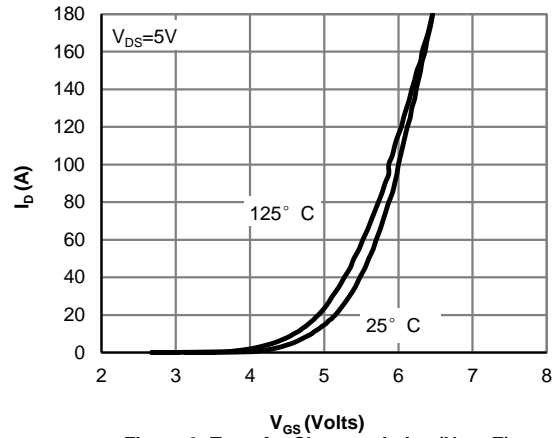


Figure 2: Transfer Characteristics (Note E)

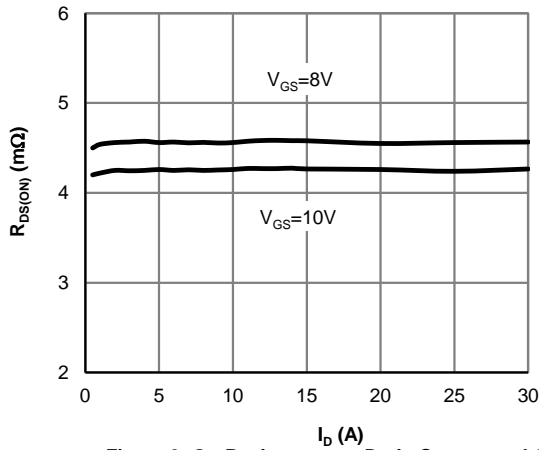


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

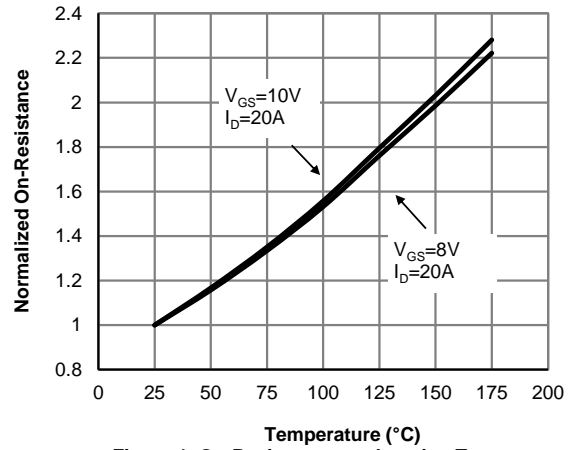


Figure 4: On-Resistance vs. Junction Temperature (Note E)

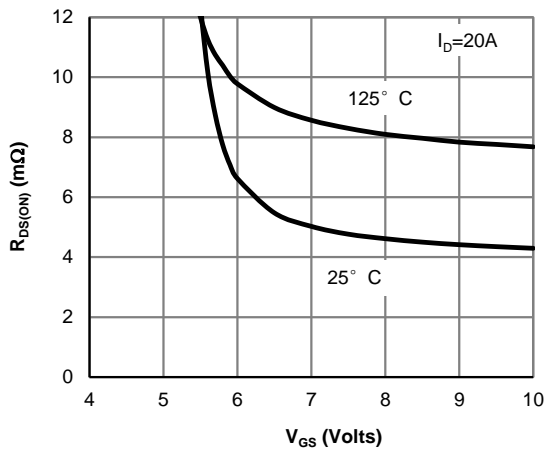


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

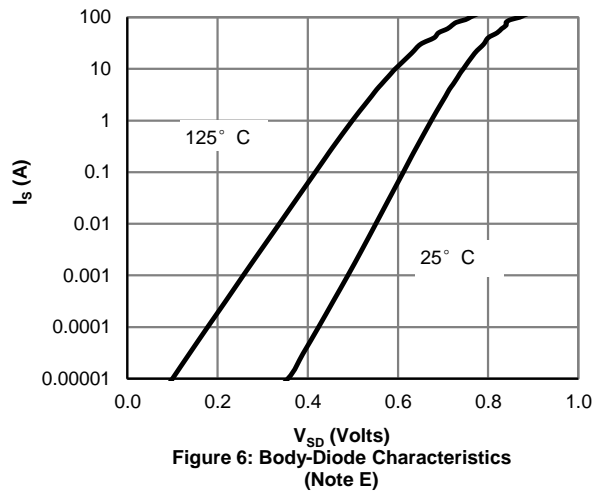


Figure 6: Body-Diode Characteristics (Note E)

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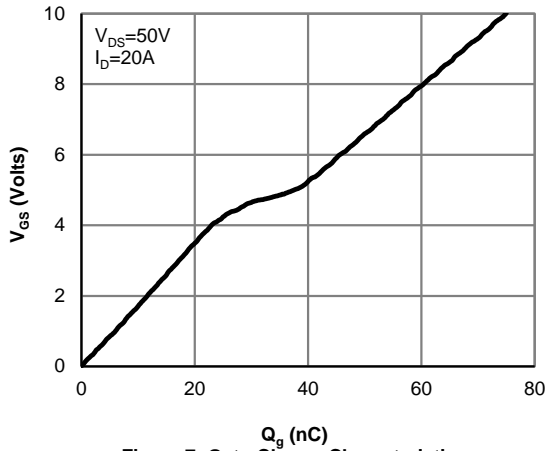


Figure 7: Gate-Charge Characteristics

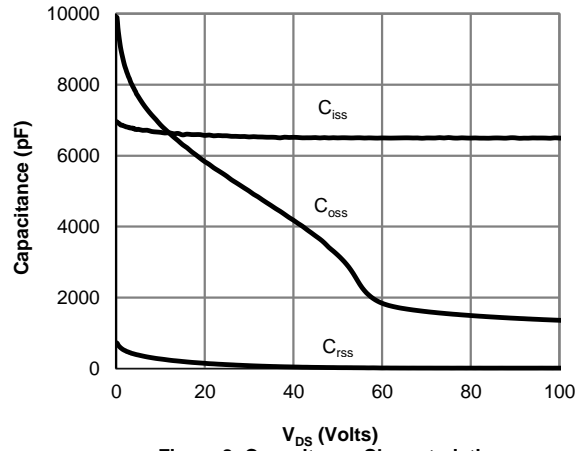


Figure 8: Capacitance Characteristics

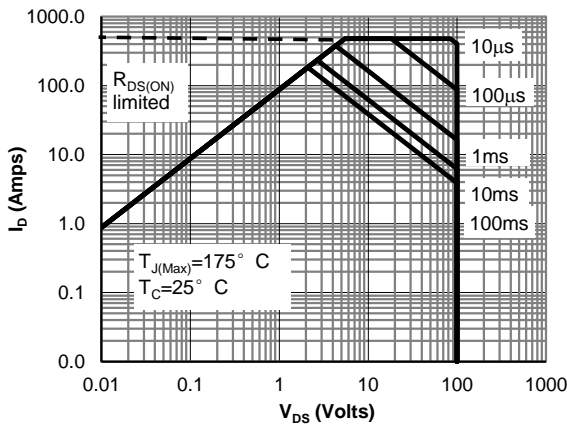


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

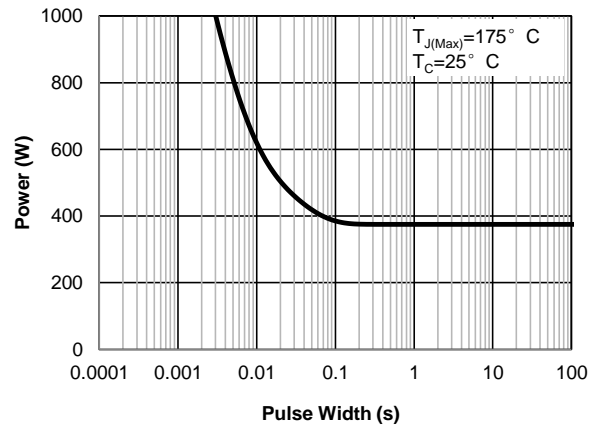


Figure 10: Single Pulse Power Rating Junction-to-Case (Note)

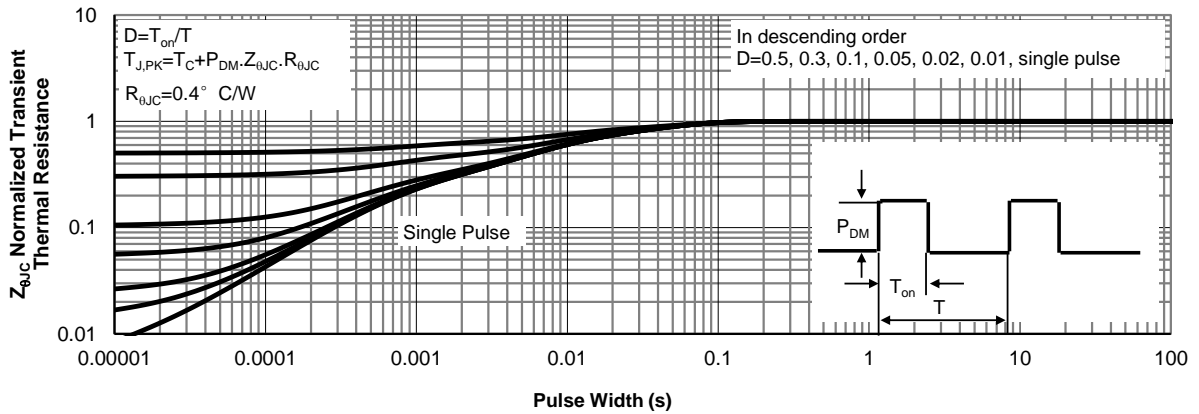


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

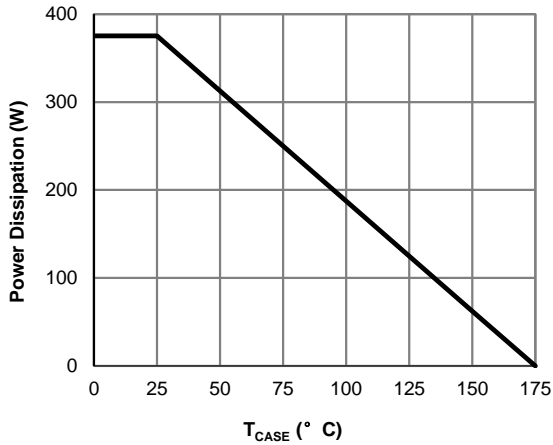


Figure 12: Power De-rating (Note F)

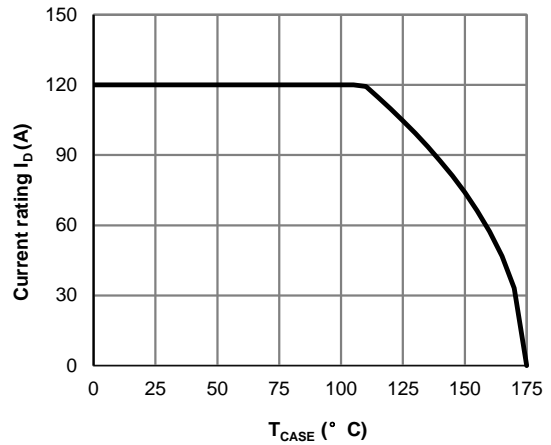


Figure 13: Current De-rating (Note F)

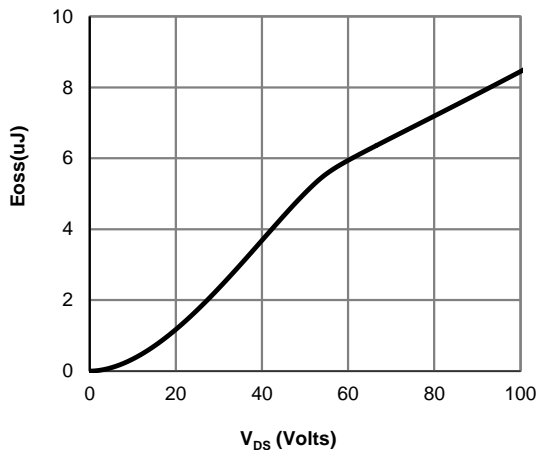


Figure 14: Coss stored Energy

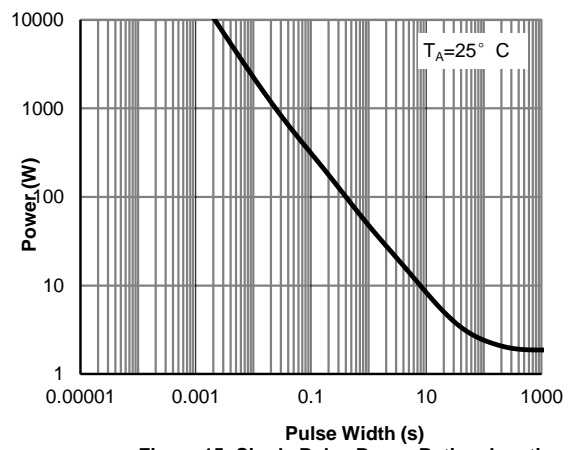


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

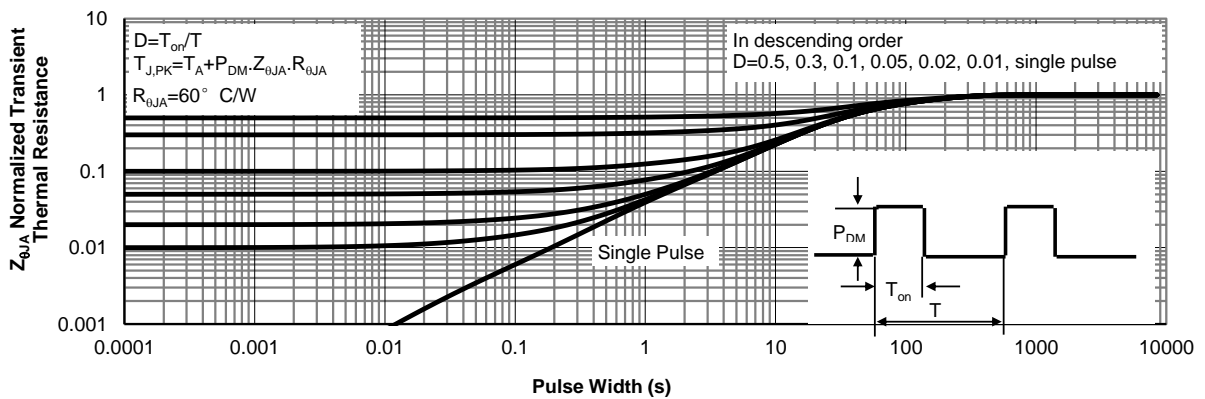


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

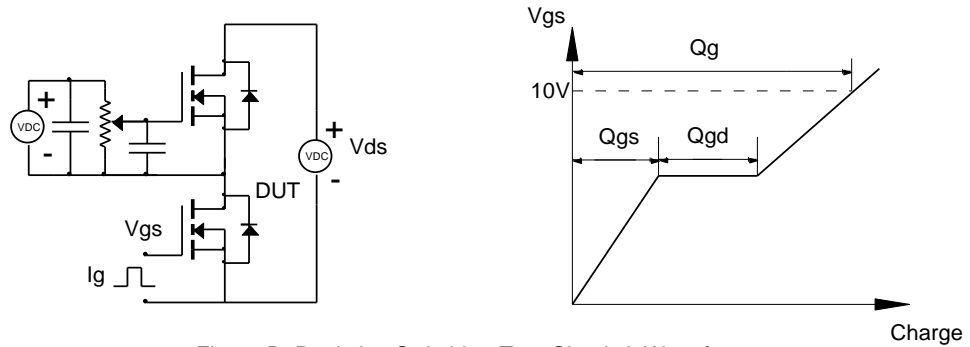


Figure B: Resistive Switching Test Circuit & Waveforms

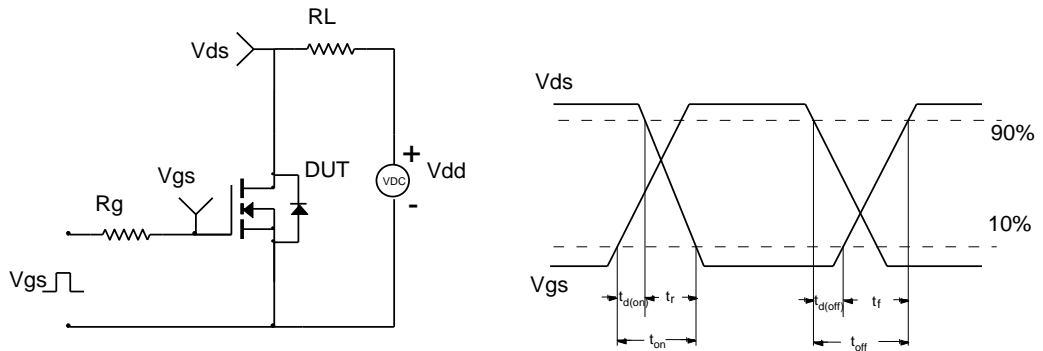


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

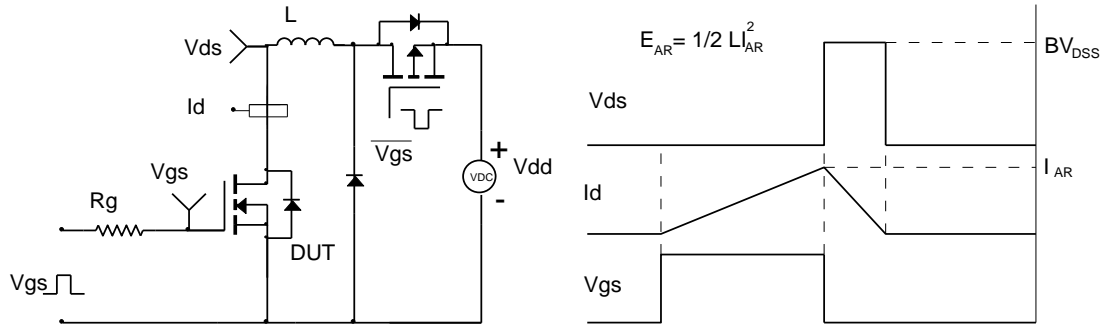


Figure D: Diode Recovery Test Circuit & Waveforms

